



POWER-MOS FET

FIELD EFFECT POWER TRANSISTOR

IRF612,613

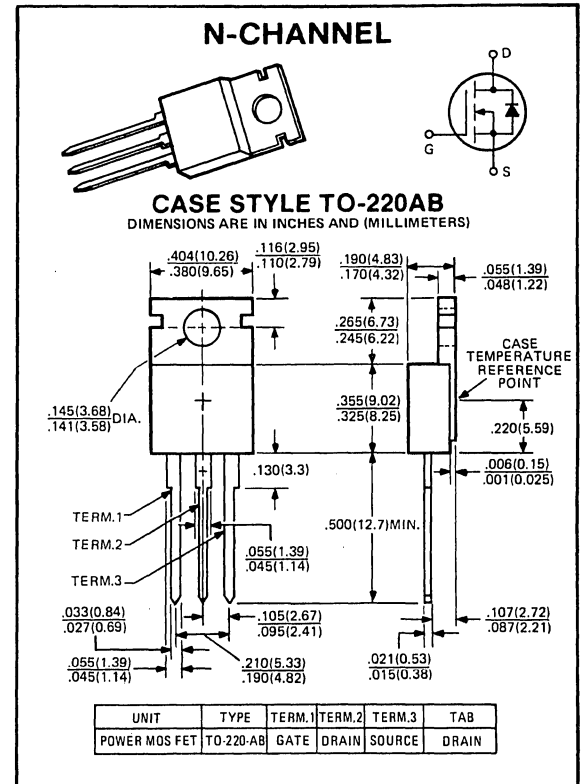
2.0 AMPERES
200, 150 VOLTS
 $R_{DS(ON)} = 2.4 \Omega$

This series of N-Channel Enhancement-mode Power MOSFETs utilizes GE's advanced Power DMOS technology to achieve low on-resistance with excellent device ruggedness and reliability.

This design has been optimized to give superior performance in most switching applications including: switching power supplies, inverters, converters and solenoid/relay drivers. Also, the extended safe operating area with good linear transfer characteristics makes it well suited for many linear applications such as audio amplifiers and servo motors.

Features

- Polysilicon gate — Improved stability and reliability
- No secondary breakdown — Excellent ruggedness
- Ultra-fast switching — Independent of temperature
- Voltage controlled — High transconductance
- Low input capacitance — Reduced drive requirement
- Excellent thermal stability — Ease of paralleling



maximum ratings ($T_C = 25^\circ\text{C}$) (unless otherwise specified)

| RATING | SYMBOL | IRF612 | IRF613 | UNITS |
|---------------------------------------------------------------------------------------|----------------|-------------|-------------|-----------------------------|
| Drain-Source Voltage | V_{DSS} | 200 | 150 | Volts |
| Drain-Gate Voltage, $R_{GS} = 1M\Omega$ | V_{DGR} | 200 | 150 | Volts |
| Continuous Drain Current @ $T_C = 25^\circ\text{C}$ @ $T_C = 100^\circ\text{C}$ | I_D | 2.0 1.25 | 2.0 1.25 | A A |
| Pulsed Drain Current ⁽¹⁾ | I_{DM} | 8 | 8 | A |
| Gate-Source Voltage | V_{GS} | ± 20 | ± 20 | Volts |
| Total Power Dissipation @ $T_C = 25^\circ\text{C}$ Derate Above 25°C | P_D | 20 0.16 | 20 0.16 | Watts $W/^\circ\text{C}$ |
| Operating and Storage Junction Temperature Range | T_J, T_{STG} | -55 to 150 | -55 to 150 | $^\circ\text{C}$ |

thermal characteristics

| | | | | |
|---------------------------------------------------------------------------------------------|-----------------|-----|-----|--------------------|
| Thermal Resistance, Junction to Case | $R_{\theta JC}$ | 6.4 | 6.4 | $^\circ\text{C/W}$ |
| Thermal Resistance, Junction to Ambient | $R_{\theta JA}$ | 80 | 80 | $^\circ\text{C/W}$ |
| Maximum Lead Temperature for Soldering Purposes: $\frac{1}{8}$ " from Case for 5 Seconds | T_L | 260 | 260 | $^\circ\text{C}$ |

(1) Repetitive Rating: Pulse width limited by max. junction temperature.

electrical characteristics ($T_C = 25^\circ\text{C}$) (unless otherwise specified)

| CHARACTERISTIC | SYMBOL | MIN | TYP | MAX | UNIT |
|----------------|--------|-----|-----|-----|------|
|----------------|--------|-----|-----|-----|------|

off characteristics

| | | | | | | |
|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------|-------------------|------------|--------|-------------|---------|
| Drain-Source Breakdown Voltage ($V_{GS} = 0V, I_D = 250\ \mu A$) | IRF612 IRF613 | BV _{DSS} | 200 150 | — — | — — | Volts |
| Zero Gate Voltage Drain Current ($V_{DS} = \text{Max Rating}, V_{GS} = 0V, T_C = 25^\circ\text{C}$) ($V_{DS} = \text{Max Rating}, \times 0.8, V_{GS} = 0V, T_C = 125^\circ\text{C}$) | | I _{DSS} | — — | — — | 250 1000 | μA |
| Gate-Source Leakage Current ($V_{GS} = \pm 20V$) | | I _{GSS} | — | — | ± 500 | nA |

on characteristics*

| | | | | | | |
|----------------------------------------------------------------------------|--------------------------|---------------------|------|------|-----|-------|
| Gate Threshold Voltage ($V_{DS} = V_{GS}, I_D = 250\ \mu A$) | $T_C = 25^\circ\text{C}$ | V _{GS(TH)} | 2.0 | — | 4.0 | Volts |
| On-State Drain Current ($V_{GS} = 10V, V_{DS} = 10V$) | | I _{D(ON)} | 2.0 | — | — | A |
| Static Drain-Source On-State Resistance ($V_{GS} = 10V, I_D = 1.25A$) | | R _{DS(ON)} | — | 1.5 | 2.4 | Ohms |
| Forward Transconductance ($V_{DS} = 10V, I_D = 1.25A$) | | g _{fs} | 0.72 | 0.75 | — | mhos |

dynamic characteristics

| | | | | | | |
|------------------------------|---------------------|------------------|---|-----|-----|----|
| Input Capacitance | $V_{GS} = 0V$ | C _{iss} | — | 120 | 150 | pF |
| Output Capacitance | $V_{DS} = 25V$ | C _{oss} | — | 40 | 80 | pF |
| Reverse Transfer Capacitance | $f = 1\ \text{MHz}$ | C _{rss} | — | 10 | 25 | pF |

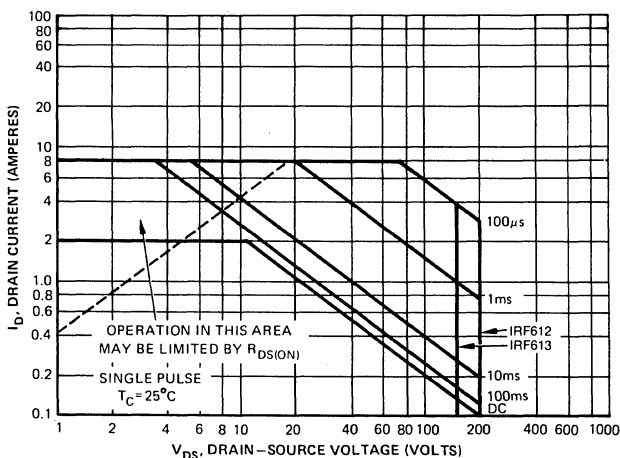
switching characteristics*

| | | | | | | |
|---------------------|-----------------------------------------------|---------------------|---|----|---|----|
| Turn-on Delay Time | $V_{DS} = 90V$ | t _{d(on)} | — | 5 | — | ns |
| Rise Time | $I_D = 1.25A, V_{GS} = 15V$ | t _r | — | 15 | — | ns |
| Turn-off Delay Time | $R_{GEN} = 50\ \Omega, R_{GS} = 12.5\ \Omega$ | t _{d(off)} | — | 10 | — | ns |
| Fall Time | ($R_{GS}\ \text{EQUIV.} = 10\ \Omega$) | t _f | — | 10 | — | ns |

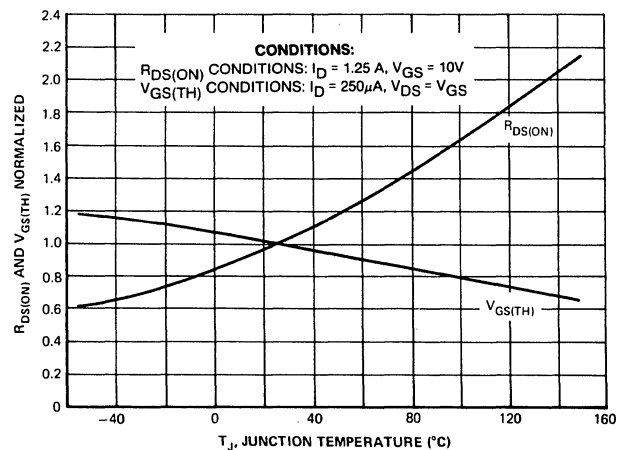
source-drain diode ratings and characteristics*

| | | | | | |
|--------------------------------------------------------------------------------------------------|------------------------------------|---|------------|-----|---------------|
| Continuous Source Current | I _S | — | — | 2.0 | A |
| Pulsed Source Current | I _{SM} | — | — | 8.0 | A |
| Diode Forward Voltage ($T_C = 25^\circ\text{C}, V_{GS} = 0V, I_S = 2.0A$) | V _{SD} | — | 0.8 | 1.8 | Volts |
| Reverse Recovery Time ($I_S = 2.5A, di_S/dt = 100A/\mu\text{sec}, T_C = 125^\circ\text{C}$) | t _{rr} Q _{RR} | — | 150 0.9 | — | ns μC |

*Pulse Test: Pulse width $\leq 300\ \mu s$, duty cycle $\leq 2\%$



MAXIMUM SAFE OPERATING AREA



TYPICAL NORMALIZED R_{DS(ON)} AND V_{GS(TH)} VS. TEMP.